

**General Description**

The 13N50A is produced using advanced high voltage MOSFET technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

**Features**

- 100% avalanche tested
- Fast Switching
- RoHS Compliant

**Absolute Maximum Ratings**

Symbol	Parameter	CMP13N50T/CMF13N50T		Units
$V_{DS}$	Drain-Source Voltage	500		V
$V_{GS}$	Gate-Source Voltage	$\pm 30$		V
$I_D @ T_C = 25^\circ\text{C}$	Continuous Drain Current	13	13*	A
$I_D @ T_C = 100^\circ\text{C}$	Continuous Drain Current	8	8*	A
$I_{DM}$	Pulsed Drain Current <sup>1</sup>	52	52*	A
EAS	Single Pulse Avalanche Energy <sup>2</sup>	722		mJ
$P_D @ T_C = 25^\circ\text{C}$	Total Power Dissipation	200	50	W
$T_{STG}$	Storage Temperature Range	-55 to 150		°C
$T_J$	Operating Junction Temperature Range	-55 to 150		°C

**Thermal Data**

Symbol	Parameter	CMP13N50T	CMF13N50T	Unit
$R_{\theta JA}$	Thermal Resistance Junction-ambient	62.5	62.5	°C/W
$R_{\theta JC}$	Thermal Resistance Junction-case	0.62	2.5	°C/W

**Electrical Characteristics ( $T_J=25^\circ\text{C}$  , unless otherwise noted)**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$ , $I_D=250\mu\text{A}$	500	---	---	V
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}}=10\text{V}$ , $I_D=6.5\text{A}$	---	---	0.41	$\Omega$
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}$ , $I_D = 250\mu\text{A}$	2	---	4	V
$I_{\text{DSS}}$	Drain-Source Leakage Current	$V_{\text{DS}}=500\text{V}$ , $V_{\text{GS}}=0\text{V}$	---	---	1	$\mu\text{A}$
		$V_{\text{DS}}=400\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $T_C=125^\circ\text{C}$	---	---	10	
$I_{\text{GSS}}$	Gate-Source Leakage Current	$V_{\text{GS}} = \pm 30\text{V}$ , $V_{\text{DS}}=0\text{V}$	---	---	$\pm 100$	nA
$g_{\text{fs}}$	Forward Transconductance	$V_{\text{DS}}=15\text{V}$ , $I_D=6.5\text{A}$	---	12	---	S
$Q_g$	Total Gate Charge	$I_D=13\text{A}$ $V_{\text{DS}}=400\text{V}$ $V_{\text{GS}}=10\text{V}$	---	45	---	nC
$Q_{\text{gs}}$	Gate-Source Charge		---	8	---	
$Q_{\text{gd}}$	Gate-Drain Charge		---	20	---	
$T_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DS}}=250\text{V}$ $I_D=13\text{A}$ $R_G=25\Omega$	---	25	---	ns
$T_r$	Rise Time		---	100	---	
$T_{\text{d(off)}}$	Turn-Off Delay Time		---	130	---	
$T_f$	Fall Time		---	100	---	
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}}=25\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $f=1\text{MHz}$	---	1900	---	pF
$C_{\text{oss}}$	Output Capacitance		---	180	---	
$C_{\text{rss}}$	Reverse Transfer Capacitance		---	9	---	

**Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$I_s$	Continuous Source Current	$V_G=V_D=0\text{V}$ , Force Current	---	---	13	A
$I_{\text{SM}}$	Pulsed Source Current		---	---	52	A
$V_{\text{SD}}$	Diode Forward Voltage	$V_{\text{GS}}=0\text{V}$ , $I_s=13\text{ A}$ , $T_J=25^\circ\text{C}$	---	---	1.5	V

Note :

- 1.Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2.1.The EAS data shows Max. rating .The test condition is  $V_{\text{DS}}=80\text{V}$  ,  $V_{\text{GS}}=10\text{V}$  ,  $L=5\text{mH}$  ,  $I_{\text{AS}}=17\text{A}$ .
- 3.Pulse Test: Pulse width $\leq 300\mu\text{s}$ , Duty Cycle $\leq 2\%$ .
- 4.Essentially Independent of Operating Temperature Typical Characteristics.

This product has been designed and qualified for the consumer market.

Cmos assumes no liability for customers' product design or applications.

Cmos reserves the right to improve product design ,functions and reliability without notice.

### Typical Characteristics

